

<IGBT Modules>

CM300DY-34T

HIGH POWER SWITCHING USE INSULATED TYPE



dual switch (half-bridge)

- •Flat base type
- •Copper base plate (Nickel-plating)
- Nickel-plating tab terminals
- •RoHS Directive compliant
- •UL Recognized under UL1557, File No.E323585

APPLICATION

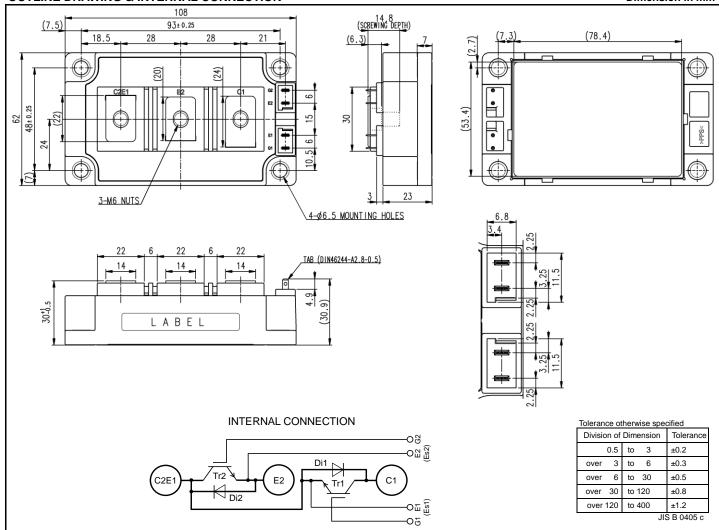
AC Motor Control, Motion/Servo Control, Power supply, etc.

OPTION (Below options are available.)

- •PC-TIM (Phase Change Thermal Interface Material) pre-apply
- •V_{CEsat} selection for parallel connection







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HIGH POWER SWITCHING USE

INSULATED TYPE

MAXIMUM RATINGS (T_{vj} =25 °C, unless otherwise specified)

| Symbol | Item | Conditions | Rating | Unit |
|--------------------------|--------------------------------|---|-------------|------|
| V _{CES} | Collector-emitter voltage | G-E short-circuited | 1700 | V |
| V_{GES} | Gate-emitter voltage | C-E short-circuited | ± 20 | V |
| Ic | Callagton augment | DC, Tc=134 °C* (Note2, 4) | 300 | ^ |
| I _{CRM} | Collector current | Pulse, Repetitive (Note3) | 600 | Α |
| P _{tot} | Total power dissipation | T _C =25 °C (Note2, 4) | 3405 | W |
| I _E (Note1) | Facilities account | DC (Note2) | 300 | ^ |
| I _{ERM} (Note1) | Emitter current | Pulse, Repetitive (Note3) | 600 | Α |
| V _{isol} | Isolation voltage | Terminals to base plate, RMS, f=60 Hz, AC 1 min | 4000 | V |
| T _{vjmax} | Maximum junction temperature | Instantaneous event (overload) | 175 | °C |
| T _{Cmax} | Maximum case temperature | | | |
| T _{vjop} | Operating junction temperature | Continuous operation (under switching) | -40 ~ +150 | °C |
| T _{stg} | Storage temperature | - | -40 ~ +150* | |

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

| Symbol | Itom | Itom | | Limits | | | Unit |
|--------------------------|--------------------------------------|---|---|--------|------|------|------|
| | Item Conditions | | | Min. | Тур. | Max. | Uni |
| I _{CES} | Collector-emitter cut-off current | V _{CE} =V _{CES} , G-E short-circuited | | - | - | 1.0 | mA |
| I _{GES} | Gate-emitter leakage current | V _{GE} =V _{GES} , C-E short-circuited | V _{GE} =V _{GES} , C-E short-circuited | | - | 0.5 | μΑ |
| $V_{GE(th)}$ | Gate-emitter threshold voltage | I _C =30 mA, V _{CE} =10 V | | 5.4 | 6.0 | 6.6 | V |
| | | I _C =300 A, V _{GE} =15 V, | T _{vj} =25 °C | - | 2.05 | 2.50 | V |
| V _{CEsat} | | Refer to the figure of test circuit | T _{vj} =125 °C | - | 2.45 | - | |
| (Terminal) | | (Note5) | T _{vj} =150 °C | - | 2.55 | - | |
| | Collector-emitter saturation voltage | I _C =300 A, | T _{vj} =25 °C | - | 1.95 | 2.35 | V |
| V _{CEsat} | | V _{GE} =15 V, | T _{vj} =125 °C | - | 2.35 | - | |
| (Chip) | | (Note5) | T _{vj} =150 °C | - | 2.45 | - | |
| Cies | Input capacitance | | | - | - | 82.5 | |
| Coes | Output capacitance | V _{CE} =10 V, G-E short-circuited | | - | - | 2.2 | nF |
| Cres | Reverse transfer capacitance | | - | - | 0.7 | | |
| Q _G | Gate charge | V _{CC} =1000 V, I _C =300 A, V _{GE} =15 V | | - | 2.35 | - | μC |
| t _{d(on)} | Turn-on delay time | V_{CC} =1000 V, I_{C} =300 A, V_{GE} =±15 V, R_{G} =0 Ω, Inductive load | | - | - | 800 | ns |
| t _r | Rise time | | | - | - | 200 | |
| t _{d(off)} | Turn-off delay time | | | - | - | 800 | |
| t _f | Fall time | | | - | - | 600 | |
| (Note 4) | - Emitter-collector voltage | I _E =300 A, G-E short-circuited, | T _{vj} =25 °C | - | 2.75 | 3.35 | V |
| V _{EC} (Note.1) | | Refer to the figure of test circuit | T _{vj} =125 °C | - | 3.00 | - | |
| (Terminal) | | (Note5) | T _{vj} =150 °C | - | 3.00 | - | |
| (Nete 4) | | I _E =300 A, | T _{vj} =25 °C | - | 2.65 | 3.20 | |
| V _{EC} (Note.1) | | G-E short-circuited, | T _{vj} =125 °C | - | 2.75 | - | V |
| (Chip) | | (Note5) | T _{vj} =150 °C | - | 2.75 | - | |
| t _{rr} (Note1) | Reverse recovery time | V _{CC} =1000 V, I _E =300 A, V _{GE} =±15 V, | | - | - | 300 | ns |
| Q _{rr} (Note1) | Reverse recovery charge | R _G =0 Ω, Inductive load | | - | 15 | - | μC |
| Eon | Turn-on switching energy per pulse | V _{CC} =1000 V, I _C =I _E =300 A, | | - | 58.5 | - | |
| E _{off} | Turn-off switching energy per pulse | V_{GE} =±15 V, R_{G} =0 Ω , T_{vj} =150 °C, | | - | 72.8 | - | mJ |
| E _{rr} (Note1) | Reverse recovery energy per pulse | Inductive load | | - | 40.6 | - | m |
| R _{CC'+EE'} | Internal lead resistance | Main terminals-chip, per switch, T _C =25 °C (Note4) | | - | 0.3 | - | mΩ |
| r _g | Internal gate resistance | Per switch | | - | 2.5 | - | Ω |

^{*:} PC-TIM applied module is restricted by the heat resistant temperature of PC-TIM.

HIGH POWER SWITCHING USE

INSULATED TYPE

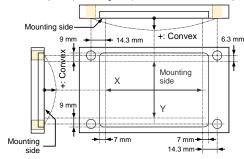
THERMAL RESISTANCE CHARACTERISTICS

| Symbol | Item | Conditions | Limits | | | Unit |
|----------------------|----------------------------|--|--------|------|------|-------|
| | item | Conditions | Min. | Тур. | Max. | Offit |
| $R_{th(j-c)Q}$ | Thermal resistance | Junction to case, per Inverter IGBT (Note4) | = | - | 44.0 | K/kW |
| $R_{th(j-c)D}$ | Thermai resistance | Junction to case, per Inverter FWD (Note4) | - | - | 67.7 | N/KVV |
| R _{th(c-s)} | Contact thermal resistance | Case to heat sink, per 1 module Thermal grease applied (Note4, 6) | - | 13.3 | - | K/kW |

MECHANICAL CHARACTERISTICS

| Symbol | Itom | Conditions | | Limits | | | l lait |
|----------------|------------------------|--------------------------------|-----------|--------|------|------|--------|
| | Item | | | Min. | Тур. | Max. | Unit |
| M _t | Mounting torque | Main terminals | M 6 screw | 3.5 | 4.0 | 4.5 | N∙m |
| Ms | Mounting torque | Mounting to heat sink | M 6 screw | 3.5 | 4.0 | 4.5 | N∙m |
| ds | Creepage distance | Terminal to terminal | | 17.3 | - | - | mm |
| | | Terminal to base plate | | 25.3 | - | - | |
| da | Clearance | Terminal to terminal | | 12.6 | - | - | |
| | Clearance | Terminal to base plate | | 21.8 | - | - | mm |
| ec | Flatness of base plate | On the centerline X, Y (Note7) | | ±0 | - | +200 | μm |
| m | mass | - | | - | 260 | - | g |

- *: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.
- Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).
 - 2. Junction temperature (T_{vj}) should not increase beyond T_{vjmax} rating.
 - 3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed $T_{vj\,m\,a\,x}$ rating.
 - 4. Case temperature (T_C) and heat sink temperature (T_S) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
 - 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
 - 6. Typical value is measured by using thermally conductive grease of λ =3.0 W/(m·K)/D_(C-S)=50 μ m.
 - 7. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



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HIGH POWER SWITCHING USE

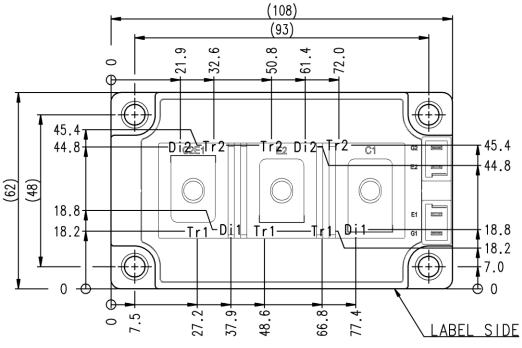
INSULATED TYPE

RECMENDED OPERATING CONDITIONS

| Symbol | Item | Conditions | Limits | | | Unit |
|-----------------|-------------------------------|--|--------|------|------|-------|
| | | | Min. | Тур. | Max. | Offic |
| V _{cc} | (DC) Supply voltage | Applied across C1-E2 terminals | - | 1000 | 1200 | V |
| V_{GEon} | Gate (-emitter drive) voltage | Applied across G1-Es1/G2-Es2 terminals | 13.5 | 15.0 | 16.5 | V |
| R _G | External gate resistance | Per switch | 0 | - | 16 | Ω |

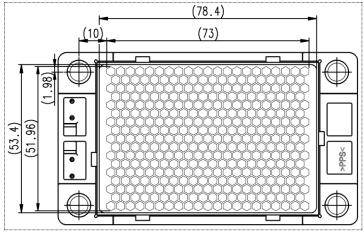
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

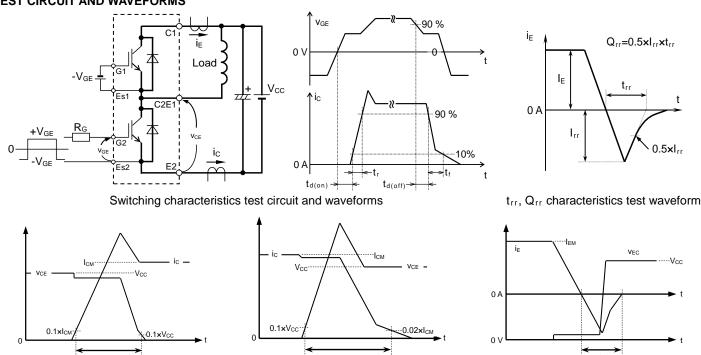


Tr1/Tr2: IGBT, Di1/Di2: FWD

Option: PC-TIM applied baseplate outline



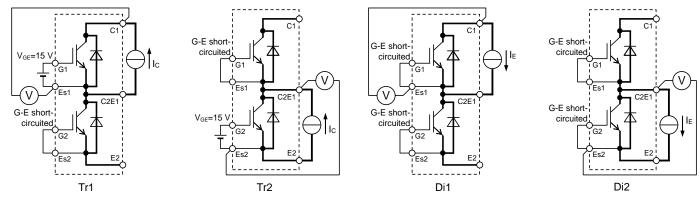
TEST CIRCUIT AND WAVEFORMS



IGBT Turn-off switching energy Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT

IGBT Turn-on switching energy

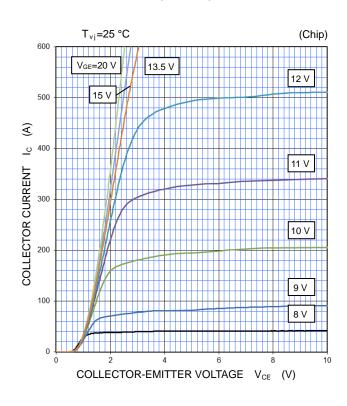


V_{CEsat} characteristics test circuit

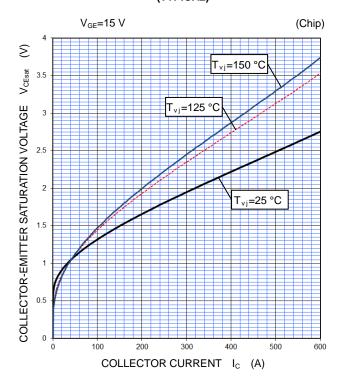
V_{EC} characteristics test circuit

FWD Reverse recovery energy

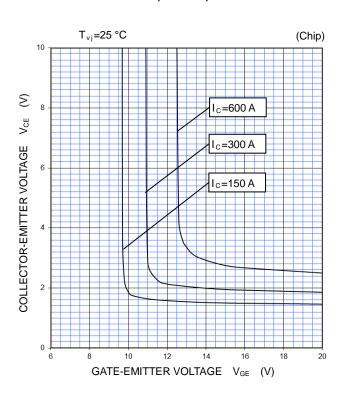
OUTPUT CHARACTERISTICS (TYPICAL)



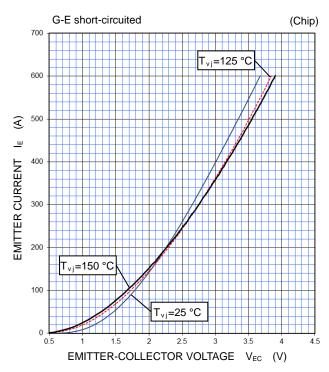
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



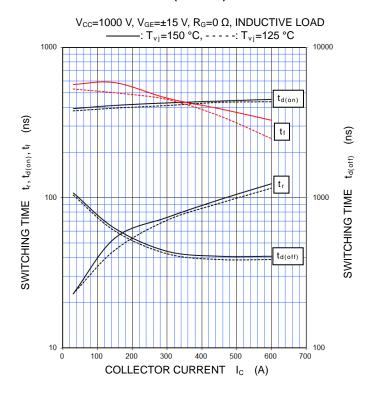
COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)



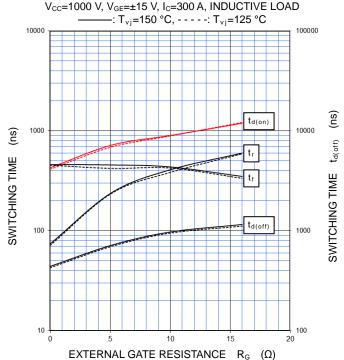
FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



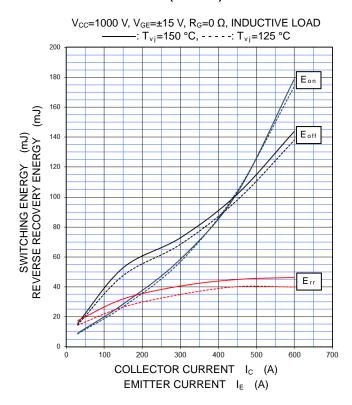
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



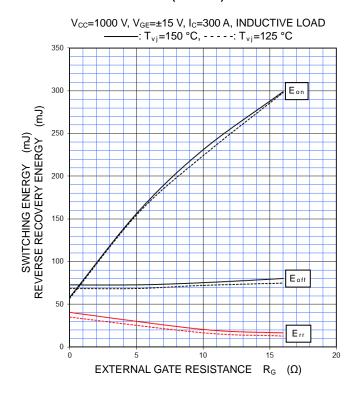
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



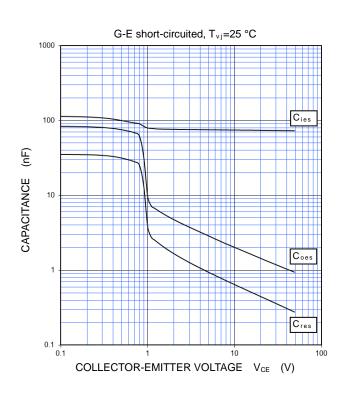
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



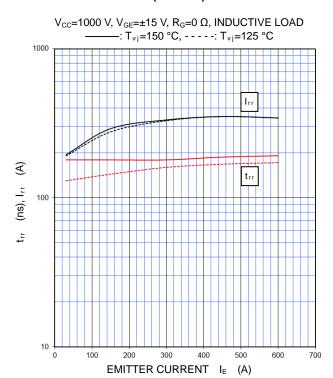
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



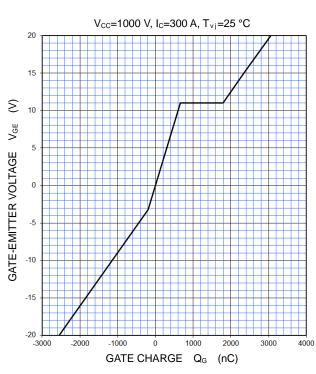
CAPACITANCE CHARACTERISTICS (TYPICAL)



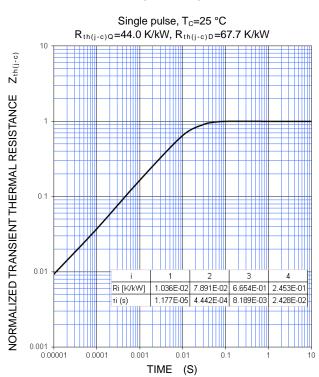
FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



GATE CHARGE CHARACTERISTICS (TYPICAL)

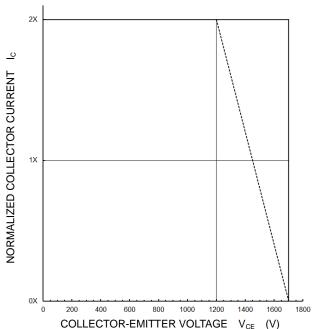


TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



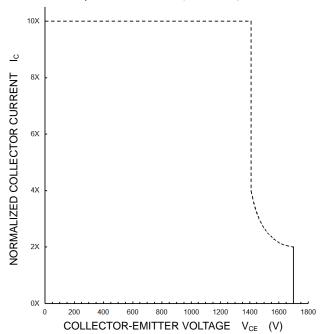
Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

TURN-OFF SWITCHING SAFE OPERATING AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)



SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)

 V_{CC} ≤1200 V, V_{GE} =±15 V, R_{G} =0~16 Ω, T_{vj} = 25 ~ 150 °C, t_{W} ≤8 μs, Non-Repetitive



HIGH POWER SWITCHING USE

INSULATED TYPE

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